

Application/Control No.	Applicant(s)/Patent under Reexamination SHIH, CHUNG-CHIN	
Chandra Chaudhari	2813	

SEARCHED				
Class	Subclass	Date	Examiner	
438	258, 263	2/3/2005	cc	
	264, 266			
	267, 286			
	634			
		_		
:				

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
438	266, 286	2/3/2005	СС	
		<del> </del>		
		<u> </u>		

(NACEODING SE	ARCH STRATE	<u> </u>
	DATE	EXMR
East text	2/3/200	s cc
<u> </u>		
		<u>:</u>
·		